







**SN54HCT08, SN74HCT08** 

SCLS063F - NOVEMBER 1988 - REVISED OCTOBER 2022

# **SNx4HCT08 Quadruple 2-Input Positive-AND Gates**

#### 1 Features

- Operating voltage range of 4.5 V to 5.5 V
- Outputs can drive up to 10 LSTTL loads
- Low power consumption, 20-µA max I<sub>CC</sub>
- Typical  $t_{pd}$  = 13 ns
- ±4-mA output drive at 5 V
- Low input current of 1 µA max
- Inputs are TTL-Voltage compatible

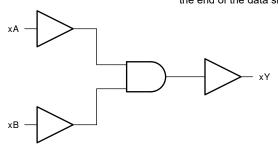
## 2 Description

These devices contain four independent 2-input AND gates. They perform the Boolean function Y = A • B in positive logic.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	BODY SIZE (NOM)
SN74HCT08D	SOIC (14)	8.65 mm × 3.90 mm
SN74HCT08DB	SSOP (14)	6.20 mm × 5.30 mm
SN74HCT08N	PDIP (14)	19.31 mm × 6.35 mm
SN74HCT08NS	SO (14)	10.20 mm × 5.30 mm
SN74HCT08PW	TSSOP (14)	5.00 mm × 4.40 mm

For all available packages, see the orderable addendum at the end of the data sheet.



**Functional Block Diagram** 



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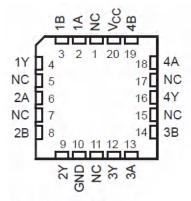
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	, .	6 to 114.8); N (80 to 67); NS (76 to 93.3); PW (113 to	
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# **4 Pin Configuration and Functions**

		_	1
1A □□□	1 ()	14	vcc
1B <u></u>	2	13	4B
1Ү ┌──	3	12	4A
2A □□	4	11	4Y
28 □□	5	10	3B
2Y 🗀	6	9	3A
GND□□□	7	8	3Y

D, DB, J, N, NS, PW or W Package 14-Pin SOIC, SSOP, PDIP, SO or TSSOP Top View



NC - No internal connection

FK Package 20-Pin LCCC Top View

# **5 Specifications**

## 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	(V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> )		±20	mA
I <sub>OK</sub>	Output clamp current <sup>(2)</sup>	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20	mA
Io	Continuous output current	(V <sub>O</sub> = 0 to V <sub>CC</sub> )		±25	mA
V <sub>CC</sub> or GND	Continuous current through		±50	mA	
TJ	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# 5.2 Recommended Operating Conditions<sup>(1)</sup>

			SNS	SN54HCT08 <sup>(2)</sup>			SN74HCT08			
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
V <sub>CC</sub> Supply voltage				5	5.5	4.5	5	5.5	V	
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2			2			V	
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V			0.8			0.8	V	
VI	Input voltage		0		V <sub>CC</sub>	0		V <sub>CC</sub>	V	
V <sub>O</sub> Output voltage					V <sub>CC</sub>	0		V <sub>CC</sub>	V	
Δt/Δv Input transition rise/fall time					500			500	ns	
T <sub>A</sub>	T <sub>A</sub> Operating free-air temperature				125	-40		85	°C	

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report Implications of Slow or Floating SMOS Inputs, literature number SCBA004.

#### 5.3 Thermal Information

		D (SOIC)	DB (SSOP)	N (PDIP)	NS (SO)	PW (TSSOP)	
THERMAL	. METRIC	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance <sup>(1)</sup>	138.7	114.8	67	93.3	159.8	°C/W
R <sub>θJC (top)</sub>	Junction-to-case (top) thermal resistance	93.8	60	55	50.9	92.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	94.7	63.8	46.7	53.8	102.1	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	49.1	19.7	35.1	17.8	40.4	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	94.3	63.1	46.5	53.3	101.7	°C/W
R <sub>θJC (bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	N/A	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> SN54HCT08 is in product preview.



#### **5.4 Electrical Characteristics**

	PARAMETER	TEST CONDITIONS(1)	V <sub>cc</sub>	T,	<sub>A</sub> = 25°C		SN54HC	CT08 <sup>(3)</sup>	SN74HCT08		UNIT	
	PARAIVIETER	TEST CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	ONII	
V	High-level output voltage	I <sub>OH</sub> = -20 μA	4.5	4.4	4.499		4.4		4.4		V	
V <sub>OH</sub> High-level output voltage		I <sub>OH</sub> = -4 mA	4.5	3.98	4.3		3.7		3.84		•	
V	Low-level output voltage	I <sub>OL</sub> = 20 μA	4.5		0.001	0.1		0.1		0.1	V	
V <sub>OL</sub> Low-level output voltage	I <sub>OL</sub> = 4 mA	4.5		0.17	0.26		0.4		0.33			
I <sub>I</sub>	Input hold current	V <sub>I</sub> = V <sub>CC</sub> or 0	5.5		±0.1	±100		±1000		±1000	nA	
I <sub>CC</sub>	Supply current	$V_I = V_{CC}$ or 0. $I_O = 0$	5.5			2		40		20	μΑ	
ΔI <sub>CC</sub> (2)	Supply-current change	One input at 0.5V or 2.4 V, Other inputs at 0 or V <sub>CC</sub>	5.5		1.4	2.4		3		2.9	mA	
C <sub>i</sub>	Input capacitance		4.5 to 5.5		3	10		10		10	pF	

- (1) V<sub>I</sub> = V<sub>IH</sub> or V<sub>IL</sub>, unless otherwise noted.
   (2) This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V<sub>CC</sub>.
- (3) SN54HCT08 is in product preview.

# 5.5 Switching Characteristics

C<sub>L</sub> = 50 pF. See Parameter Measurement Information

	PARAMETER	FROM (INPUT)	то	V <sub>CC</sub>	T <sub>A</sub> = 25°C		SN54HCT08 <sup>(1)</sup>		SN74HCT08			
FAISAMETER	PROW (INPUT)	(OUTPUT)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX		
	Propagation dolay	A or B	V	4.5		15	24		35		30	ns
t <sub>pd</sub> Propagation delay	AUB	T	5.5		13	22		32		27	115	
	Transition time	Transition time		4.5		9	15		22		19	no
Lt	t <sub>t</sub> Transition time		ſ	5.5		8	14		20		17	ns

<sup>(1)</sup> SN54HCT08 is in product preview.

## **5.6 Operating Characteristics**

 $T_A = 25^{\circ}C$ 

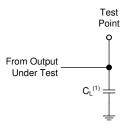
		Test Conditions	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance per gate	No load	20	pF

#### **6 Parameter Measurement Information**

Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_t$  < 6 ns.

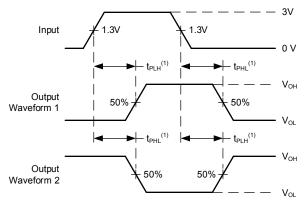
For clock inputs,  $f_{\text{max}}$  is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



(1) C<sub>L</sub> includes probe and test-fixture capacitance.

Figure 6-1. Load Circuit for Push-Pull Outputs



(1) The greater between  $t_{PLH}$  and  $t_{PHL}$  is the same as  $t_{pd}$ .

Figure 6-2. Voltage Waveforms, Propagation Delays for TTL-Compatible Inputs



# 7 Detailed Description

## 7.1 Overview

This device contains four independent 2-input AND Gates. Each gate performs the Boolean function Y = A ● B in positive logic.

# 7.2 Functional Block Diagram

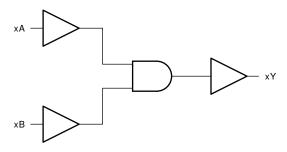


Figure 7-1. Functional Block Diagram

#### 7.3 Device Functional Modes

Function Table lists the functional modes of the SN74HCT08.

**Table 7-1. Function Table** 

INPU	TS <sup>(1)</sup>	OUTPUT
Α	В	Y
Н	Н	Н
L	Х	L
×	L	L

(1) H = High Voltage Level, L = Low Voltage Level, X = Don't Care

# 8 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V<sub>CC</sub> terminal should have a good bypass capacitor to prevent power disturbance. A 0.1-µF capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1-µF and 1-µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

#### 9 Layout

#### 9.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.

## 9.2 Layout Example

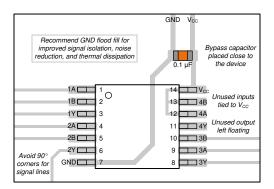


Figure 9-1. Example layout for the SN74HCT08



## 10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

#### **10.1 Documentation Support**

#### 10.1.1 Related Documentation

### 10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 10.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

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### 10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



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#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	<b>Device Marking</b> (4/5)	Samples
SN74HCT08D	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-40 to 85	HCT08	
SN74HCT08DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT08	Samples
SN74HCT08DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	HCT08	Samples
SN74HCT08DRE4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT08	Samples
SN74HCT08DRG4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT08	Samples
SN74HCT08N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HCT08N	Samples
SN74HCT08NE4	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HCT08N	Samples
SN74HCT08NSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT08	Samples
SN74HCT08PW	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-40 to 85	HT08	
SN74HCT08PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	HT08	Samples
SN74HCT08PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT08	Samples
SN74HCT08PWT	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-40 to 85	HT08	

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



# **PACKAGE OPTION ADDENDUM**

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- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HCT08DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74HCT08DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HCT08DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HCT08NSR	so	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74HCT08PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HCT08PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HCT08DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74HCT08DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74HCT08DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74HCT08NSR	SO	NS	14	2000	356.0	356.0	35.0
SN74HCT08PWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74HCT08PWR	TSSOP	PW	14	2000	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74HCT08N	N	PDIP	14	25	506	13.97	11230	4.32
SN74HCT08N	N	PDIP	14	25	506	13.97	11230	4.32
SN74HCT08NE4	N	PDIP	14	25	506	13.97	11230	4.32
SN74HCT08NE4	N	PDIP	14	25	506	13.97	11230	4.32

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
  - Sody length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



## **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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